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 Nine Differential Channels for the Data and Control Paths of the Differential Small 	_	DL PAC (TOP \	CKAGE VIEW)
Computer Systems Interface (SCSI) and Intelligent Peripheral Interface (IPI-2)	GND [56] CDE2
 Meets or Exceeds the Requirements of ANSI Standard RS-485 and 	BSR [CRE [55 CDE1 54 CDE0
ISO 8482:1987(E)	<u>1A</u>	4	53 9B+
Packaged in Shrink Small-Outline Package		5	52 9B-
With 25-mil Terminal Pitch	2A	6	51 8B+
 Designed to Operate at 10 Million Transfers 		7	50 8B-
Per Second	3A [3DE/RE [8	49 7B+ 48 7B-
Low Disabled Supply Current	3DE/RE [4A [9 10	40 1 7 B - 47 6B +
1.4 mA Typical	4DE/RE	10	46 6B –
Thermal-Shutdown Protection	V _{CC}	12	45 VCC
Power-Up/Power-Down Glitch Protection	GND	1	44] GND
• Positive and Negative Output-Current	GND	14	43 🛛 GND
Limiting	GND	15	42 🛛 GND
 Open-Circuit Fail-Safe Receiver Design 	GND [16	41 🛛 GND
	GND [17	40] GND
description	V _{CC} [18	39] V _{CC}
•	5A [19	³⁸] 5B+
The SN75LBC976 is a nine-channel differential	5DE/RE	1	³⁷ 5B-
transceiver based on the 75LBC176 LinASIC™	<u>6A</u>	21	36 4B+
cell. Use of TI's LinBiCMOS™ [†] process	6DE/RE		35] 4B-
technology allows the power reduction necessary to integrate nine differential transceivers. On-chip		23 24	³⁴ 3B+
enabling logic makes this device applicable for the	7DE/RE	24 25	³³ 3B- ³² 2B+
data path (eight data bits plus parity) and the	8A [8DE/RE [4	³²] 2B+ ³¹] 2B-
			~· [] ZD –

Pins 13 through 17 and 40 through 44 are connected together to the package lead frame and signal ground.

27

28

30 1 1B+

1B-

29

9DE/RE

9A

The switching speed and testing capabilities of the SN75LBC976 are sufficient to transfer data over the data bus at 10 million transfers per second. Each of the nine channels conforms to the requirements of the ANSI RS-485 and ISO 8482:1987(E) standards referenced by ANSI X3.129-1986 (IPI), ANSI X3.131-1993 (SCSI-2), and the proposed SCSI-3 standards.

The SN75LBC976 is characterized for operation from 0°C to 70°C.

[†]Patent pending LinASIC and LinBiCMOS are trademarks of Texas Instruments Incorporated.

control path (nine bits) for both the Small

Computer Systems Interface (SCSI) and the

Intelligent Peripheral Interface (IPI-2) standard

The SN75LBC976 is packaged in a shrink

small-outline package (DL) with improved thermal characteristics using heat-sink terminals. This package is ideal for low-profile, space-restricted

applications such as hard disk drives.

data interfaces.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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logic diagram (positive logic)[†]



[†] For additional logic diagrams, see Application Information, Table 1 and Figures 7 through 44.



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schematics of inputs and outputs

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} (see Note 1)	
Bus voltage range	–10 V to 15 V
Data I/O and control (A-side) voltage range	\dots -0.3 V to 7 V
Continuous power dissipation	internally limited
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range, T _{stg}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to GND.



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recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.75	5	5.25	V
	B+ or B-			12	
Voltage at any bus terminal (separately or common-mode), $V_{\mbox{O}},V_{\mbox{I}},\text{or}V_{\mbox{IC}}$	B+ or B-			-7	V
High-level input voltage, VIH	All except B+ and B-	2			V
Low-level input voltage, VIL	All except B+ and B-			0.8	V
	B+ or B-			-60	mA
High-level output current, IOH	А			-8	mA
Level and a development of	B+ or B-			60	mA
Low-level output current, I _{OL} A				8	mA
Operating free-air temperature, T _A	<u>.</u>	0		70	°C

device electrical characteristics over recommended ranges of operating conditions (unless otherwise noted)

	PARAMETE	R	TEST C	ONDITIONS	MIN	TYP†	MAX	UNIT
	Link lovel insert expressed	BSR, A, DE/RE, and CRE		N 0.V			-200	μΑ
ЧΗ	High-level input current	CDE0, CDE1, and CDE2		V _{IH} = 2 V			100	μΑ
	Low lovel innet compat	BSR, A, DE/RE, and CRE	See Figure 1	Ŭ			-200	μΑ
۱Ľ	Low-level input current	CDE0, CDE1, and CDE2		V _{IL} = 0.8 V			100	μΑ
		All drivers and receivers disabled	BSR and CDE0 at 5 V, Other inputs at 0 V			1.4	3	mA
ICC	Supply current	All receivers enabled	No load, All other input	V _{ID} = 5 V, s at 0 V		29	45	mA
		All drivers enabled	BSR at 0 V, All other input	No load, s at 5 V		4.8	10	mA
CO	Bus port output capacitance		B+ or B-			16		pF
	Device dissingtion considered [†]		One driver			460		pF
Cpd	Power dissipation capacitance‡		One receiver			50		pF

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡]C_{pd} determines the no-load dynamic current consumption; I_S = C_{pd} · V_{CC} · f + I_{CC}.

driver electrical characteristics over recommended ranges of operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOD	Differential output voltage	$V_{test} = -7 V \text{ to } 12 V$, See Figure 2	1	2		V
IOS	Output short-circuit current	See Figure 3			±250	mA
IOZ	High-impedance-state output current	See receiver input current				



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PARAMETER **TEST CONDITIONS** MIN TYP[†] MAX UNIT $V_{ID} = 200 \text{ mV},$ $I_{OH} = -8 \text{ mA},$ ٧он High-level output voltage 2.5 V See Figure 1 $V_{ID} = -200 \text{ mV},$ $I_{OL} = 8 \text{ mA},$ V_{OL} Low-level output voltage 0.8 V See Figure 1 Positive-going input threshold voltage 0.2 V VIT+ $I_{OH} = -8 \text{ mA},$ See Figure 1 Negative-going input threshold voltage See Figure 1 -0.2 V $I_{OL} = 8 \text{ mA},$ VIT-Receiver input hysteresis voltage $(V_{IT+} - V_{IT-})$ Vhys 45 mV $V_{CC} = 5 V_{,}$ $V_{I} = 12 V_{,}$ 0.7 1 mΑ Other input at 0 V, See Figure 1 $V_{I} = 12 V_{z}$ $V_{CC} = 0,$ 1 0.8 mΑ Other input at 0 V, See Figure 1 Receiver input current B+ and Bh. $V_{I} = -7 V_{,}$ $V_{CC} = 5 V,$ -0.8 -0.5 mΑ Other input at 0 V, See Figure 1 $V_{I} = -7 V_{.}$ $V_{CC} = 0,$ -0.4-0.8 mΑ Other input at 0 V, See Figure 1 $V_0 = GND$ -200 See Figure 1 High-impedance-state output current μΑ loz $V_{O} = V_{CC}$ 50

receiver electrical characteristics over recommended ranges of operating conditions (unless otherwise noted)

driver switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 4)

	PARAMETER		NDITIONS	MIN	түр†	MAX	UNIT
				7.6		19.6	
^t d(OD)			$T_A = 25^{\circ}C$	9.1		17.1	ns
. ,			$T_A = 70^\circ C$	11.5		19.5	
	Skew limit, the maximum difference in propagation delay times					12	
^t sk(lim)	between any two drivers on any two devices	$V_{CC} = 5 V,$	See Note 2			8	ns
t _{sk(p})	Pulse skew (t _{d(ODL)} - t _{d(ODH)})				0	6	ns
tt	Transition time (t _r or t _f)				10		ns

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

NOTE 2: This specification applies to any 5°C band within the operating temperature range.



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receiver switching characteristics over recommended operating conditions (see Figure 5) (unless otherwise noted)

	PARAMETER	TEST CO	NDITIONS	MIN	TYP†	MAX	UNIT
				21.5		33	
^t pd	Propagation delay time, high- to low-level output (tpLH) or low- to high-level output (tpHI)		$T_A = 25^{\circ}C$	22.6		31.6	ns
		V _{CC} = 5 V,	$T_A = 70^{\circ}C$	23.4		32.4	
	Skew limit, the maximum difference in propagation delay times					12	
^t sk(lim)	between any two drivers on any two devices	V _{CC} = 5 V,	See Note 2			9	ns
t _{sk(p})	Pulse skew (tpHL - tpLH)				2	6	ns
tt	Transition time (t _r or t _f)				3		ns

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C.

NOTE 2: This specification applies to any 5°C band within the operating temperature range.

transceiver switching characteristics over recommended operating conditions

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
ten(RXL)	Enable time, transmit-to-receive to low-level output			150	ns
ten(RXH)	Enable time, transmit-to-receive to high-level output			150	ns
ten(TXL)	Enable time, receive-to-transmit to low-level output	See Figure 6		80	ns
ten(TXH)	Enable time, receive-to-transmit to high-level output			80	ns
t _{su}	Setup time, CDE0, CDE1, CDE2, BSR, or CRE to active input(s) or output(s)		150		ns

thermal characteristics

PARAMETER		TEST CONI	MIN	TYP	MAX	UNIT	
$R_{\theta JA}$	Junction-to-free-air thermal resistance	Board mounted,	No air flow		50		°C/W
$R_{\theta JC}$	Junction-to-case thermal resistance				12		°C/W

PARAMETER MEASUREMENT INFORMATION



NOTE A: For the $I_{\mbox{\scriptsize OZ}}$ measurement, BSR is at 5 V and CDE0, CDE1, and CDE2 are at 0 V.

Figure 1. Receiver Test Circuit and Input Conditions



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PARAMETER MEASUREMENT INFORMATION





NOTE A: For the $I_{\mbox{OZ}}$ test, the BSR input is at 5 V and all others are at 0 V.

Figure 3. Driver Test Circuit and Input Conditions



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PARAMETER MEASUREMENT INFORMATION

VOLTAGE WAVEFORMS

[†] Includes probe and jig capacitance.

NOTE A: The input is provided by a pulse generator with an output of 0 to 3 V, PRR of 1 MHz, 50% duty cycle, t_r and $t_f < 6$ ns, and $Z_O = 50 \Omega$.

Figure 4. Driver Test Circuit and Voltage Waveforms



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PARAMETER MEASUREMENT INFORMATION

[†] Includes probe and jig capacitance.

NOTE A: The input is provided by a pulse generator with an output of 0 to 3 V, PRR of 1 MHz, 50% duty cycle, t_r and t_f < 6 ns, and Z_O = 50 Ω .

Figure 5. Receiver Test Circuit and Voltage Waveforms



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PARAMETER MEASUREMENT INFORMATION

[†] Includes probe and jig capacitance.

NOTE A: The input is provided by a pulse generator with an output of 0 to 3 V, PRR of 1 MHz, 50% duty cycle, t_r and $t_f < 6$ ns, and $Z_O = 50 \Omega$.

Figure 6. Enable Time Test Circuit and Voltage Waveforms



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TYPICAL CHARACTERISTICS

Figure 7







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TYPICAL CHARACTERISTICS



Figure 12



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TYPICAL CHARACTERISTICS

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TYPICAL CHARACTERISTICS



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SIGNAL	TERMINAL	SCSI DATA	SCSI CONTROL	IPI DATA	IPI CONTROL
CDE0	54	DIFFSENSE	DIFFSENSE	VCC	V _{CC}
CDE1	55	GND	GND	XMTA, XMTB	GND
CDE2	56	GND	GND	XMTA, XMTB	SLAVE/MASTER
BSR	2	GND	GND	GND, BSR	GND
CRE	3	GND	GND	GND	VCC
1A	4	DB0, DB8	ATN	AD7, BD7	NOT USED
1DE/RE	5	DBE0, DBE8	INIT EN	GND	GND
2A	6	DB1, DB9	BSY	AD6, BD6	NOT USED
2DE/RE	7	DBE1, DBE9	BSY EN	GND	GND
ЗA	8	DB2, DB10	ACK	AD5, BD5	SYNC IN
3DE/RE	9	DBE2, DBE10	INIT EN	GND	GND
4A	10	DB3, DB11	RST	AD4, BD4	SLAVE IN
4DE/RE	11	DBE3, DBE11	GND	GND	GND
5A	19	DB4, DB12	MSG	AD3, BD3	NOT USED
5DE/RE	20	DBE4, DBE12	TARG EN	GND	GND
6A	21	DB5, DB13	SEL	AD2, BD2	SYNC OUT
6DE/RE	22	DBE5, DBE13	SEL EN	GND	GND
7A	23	DB6, DB14	C/D	AD1, BD1	MASTER OUT
7DE/RE	24	DBE6, DBE14	TARG EN	GND	GND
8A	25	DB7, DB15	REQ	AD0, BD0	SELECT OUT
8DE/RE	26	DBE7, DBE15	TARG EN	GND	GND
9A	27	DBP0, DBP1	I/O	AP, BP	ATTENTION IN
9DE/RE	28	DBPE0, DBPE1	TARG EN	XMTA, XMTB	V _{CC}

Table 1. Typical Signal and Terminal Assignments

ABBREVIATIONS:

DBn, data bit n, where $n = (0, 1, \ldots, 15)$

DBEn, data bit n enable, where n = (0, 1, ..., 15)

DBP0, parity bit for data bits 0 through 7 or IPI bus A

DBPE0, parity bit enable for P0

DBP1, parity bit for data bits 8 through 15 or IPI bus B

DBPE1, parity bit enable for P1

ADn or BDn, IPI Bus A – Bit n (ADn) or Bus B – Bit n (BDn), where n = (0, 1, ..., 7)

AP or BP, IPI parity bit for bus A or bus B

XMTA or XMTB, transmit enable for IPI bus A or B

BSR, bit significant response

INIT EN, common enable for SCSI initiator mode

TARG EN, common enable for SCSI target mode

NOTE: Signal inputs are shown as active high. If only active-low inputs are available, logic inversion is accomplished by reversing the B + and B – connecter terminal assignments.



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Function Tables

RECEIVER



INP	OUTPUT	
в+†	в_†	Α
L	Н	L
Н	L	Н

TRANSCEIVER



						TS
DE/RE	Α	в+†	в_†	Α	B+	В-
L	_	L	Н	L	-	-
L	_	Н	L	Н	_	_
н	L	_	-	-	L	Н
Н	Н	-	-	-	Н	L

WIRED-OR DRIVER



INPUT	OUTPUTS		
Α	B+	В-	
L	Z	Ζ	
н	н	L	

DRIVER



INPUT	OUTPUTS		
Α	B+	В-	
L	L	Н	
Н	Н	L	

DRIVER WITH ENABLE



INPUTS		OUTPUTS		
DE/RE	Α	B+	В-	
L	L	Z	Z	
L	Н	Z	Z	
Н	L	L	н	
Н	Н	н	L	

TWO-ENABLE INPUT DRIVER



INPUTS		OUTPUTS		
DE/RE	Α	B+	В-	
L	L	Z	Z	
L	Н	н	L	
н	L	L	Н	
Н	Н	Н	L	

H = high level, L = low level, X = irrelevant, Z = high impedance (off)

[†] An H in this column represents a voltage 200 mV higher than the other bus input. An L represents a voltage 200 mV lower than the other bus input. Any voltage less than 200 mV results in an indeterminate receiver output.



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[†] If 0, is open drain

[‡] Must be open-drain or 3-state output

NOTE: The BSR, CRE, A, and DE/RE inputs have internal pullups. CDE0, CDE1, and CDE2 have internal pulldowns.

Figure 20. Typical SCSI Transceiver Connections



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channel logic configurations with control input logic

The following logic diagrams show the positive-logic representation for all combinations of control inputs. The control inputs are from MSB to LSB; BSR, CDE0, CDE1, CDE2, and \overline{CRE} , and are shown below the diagrams. Channel 1 is at the top and channel 9 is at the bottom of the logic diagrams.



Figure 21. 00000

Figure 22. 00001

Figure 23. 00010

Figure 24. 00011

Figure 25. 00100



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Figure 30. 01001

Figure 29. 01000



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Figure 34. 01101

Figure 35. 01110



Figure 32. 01011

Figure 33. 01100



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Figure 40. 10110 and 10111



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Hi-Z

Figure 41. 11000 and 11001





Figure 42. 11010 and 11011 Figure 43. 11100 and 11101

Hi-Z



Hi-Z

Figure 44. 11110 and 11111





PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN75LBC976DLR	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

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OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

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⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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